Serial No. 10/530,322 Docket No. US01-04071PCT

FUJ1.072

AMENDMENTS TO THE CLAIMS

Please amend the claims as follows:

1. (Currently Amended) A Group III nitride semiconductor light-emitting element including an n-type contact layer of n-type GaN, an n-type clad layer of n-type Al_xGa_{1-x}N (0<x<1), an active layer, a p-type clad layer, and a p-type contact layer, comprising:

a crack-preventing layer of n-type GaN provided between the n-type contact layer and the n-type clad layer,

wherein the crack-preventing layer has a dopant concentration lower than that of the n-type contact layer, the dopant concentration of the crack-preventing layer being within a range of 5 x 10^{16} cm⁻³ to 5 x 10^{17} cm⁻³.

2.-3. (Canceled)

- 4. (Original) The light-emitting element according to claim 1, wherein the n-type contact layer has a dopant concentration within a range of 4 x 10^{18} cm⁻³ to 2 x 10^{19} cm⁻³.
- 5. (Original) The light-emitting element according to claim 1, wherein a dopant of the crack-preventing layer is either one of Si and Ge.
- 6. (Original) The light-emitting element according to claim 1, wherein a dopant of the n-type contact layer is either one of Si and Ge.

7.-8. (Canceled)

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9. (New) The light-emitting element according to claim 1, wherein the light-emitting element comprises a vertical, two-terminal discrete device.

10. (New) The light-emitting element according to claim 1, wherein a driving current light emission of said light emitting element flows in a single direction from a first terminal to a second terminal.

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